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AON7502

30V N-Channel AlphaMOS

General Description

- Latest Trench Power AlphaMOS (αMOS LV) technology
- Very Low RDS(on) at 6V_{GS}
- Low Gate Charge
- High Current Capability
- RoHS and Halogen-Free Compliant

Application

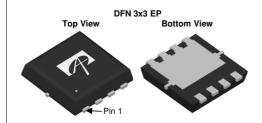
- Load Switch Applications
- Battery Power Management

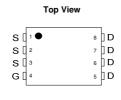
Product Summary

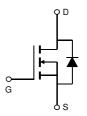
 $\begin{array}{ll} V_{DS} & 30V \\ I_D \ (at \ V_{GS} = 10V) & 30A \\ R_{DS(ON)} \ (at \ V_{GS} = 10V) & < 4.7 m\Omega \\ R_{DS(ON)} \ (at \ V_{GS} = 6V) & < 7.6 m\Omega \end{array}$

100% UIS Tested 100% R_g Tested









Absolute Maximum	Ratings T ₄ =25°C unles	s otherwise noted
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Parameter		Symbol	Maximum	Units		
Drain-Source Voltage		V _{DS}	30	V		
Gate-Source Voltage		V_{GS}	±25	V		
Continuous Drain T _C =25°C			30			
Current ^G	T _C =100°C	I _D	23.5	A		
Pulsed Drain Current C		I _{DM}	120	7		
Continuous Drain	T _A =25°C		21	٨		
Current	T _A =70°C	IDSM	17	— A		
Avalanche Current ^C		I _{AS}	30	Α		
Avalanche energy L=0.05mH ^C		E _{AS}	23	mJ		
V _{DS} Spike	100ns	V _{SPIKE}	36	V		
	T _C =25°C	31		W		
Power Dissipation ^B	T _C =100°C	P _D	12.5	VV		
	T _A =25°C	В	3.1	14/		
Power Dissipation A T _A =70°C		P _{DSM}	2	W		
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	°C		

Thermal Characteristics							
Parameter		Symbol	Тур	Max	Units		
Maximum Junction-to-Ambient A	t ≤ 10s	В	30	40	°C/W		
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	60	75	°C/W		
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	3.2	4	°C/W		



Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC F	PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$		30			V
lass	Zero Gate Voltage Drain Current	V_{DS} =30V, V_{GS} =0V				1	μА
I _{DSS}			T _J =55°C			5	μΑ
I _{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} = ±25V				100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS,} I_D = 250 \mu A$		1.4	2.2	3	V
	Static Drain-Source On-Resistance	V_{GS} =10V, I_D =20A			3.9	4.7	mΩ
$R_{DS(ON)}$			T _J =125°C		5.5	6.7	ms2
		V_{GS} =6V, I_D =20A			6	7.6	mΩ
g _{FS}	Forward Transconductance	V _{DS} =5V, I _D =20A			85		S
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V			0.71	1	V
I _S	Maximum Body-Diode Continuous Cur	Current ^G				30	Α
C_{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =15V, f=1MHz V _{GS} =0V, V _{DS} =0V, f=1MHz			1022		pF
Coss	Output Capacitance				574		pF
C _{rss}	Reverse Transfer Capacitance				63		pF
R_g	Gate resistance			1.1	2.2	3.3	Ω
SWITCHI	NG PARAMETERS						
$Q_g(10V)$	Total Gate Charge			15.6	22	nC	
Q _g (4.5V)	Total Gate Charge	V _{GS} =10V, V _{DS} =15V, I _D =20A			6.2	12	nC
Q_{gs}	Gate Source Charge				4.8		nC
Q_{gd}	Gate Drain Charge				3.5		nC
t _{D(on)}	Turn-On DelayTime				7.5		ns
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =15V, R_L =0.75 Ω , R_{GEN} =3 Ω			4		ns
t _{D(off)}	Turn-Off DelayTime				17.5		ns
t _f	Turn-Off Fall Time				4.3		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, dI/dt=500A/μs			15.3		ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =20A, dI/dt=500A/μ	S		20		nC

A. The value of R_{0JA} is measured with the device mounted on $1in^2$ FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on R_{0JA} t≤ 10s and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

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B. The power dissipation P_D is based on $T_{J_{(MAX)}}$ =150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature $T_{J(MAX)}$ =150° C.

D. The $R_{\theta,JA}$ is the sum of the thermal impedance from junction to case $R_{\theta,JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

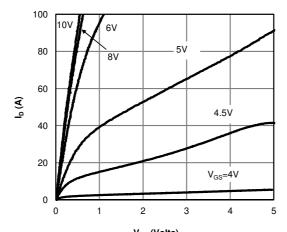
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}=150^{\circ}$ C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

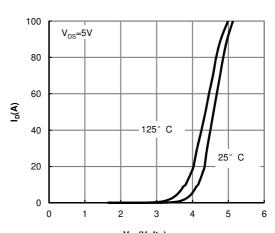
H. These tests are performed with the device mounted on 1 in FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^{\circ}$ C.



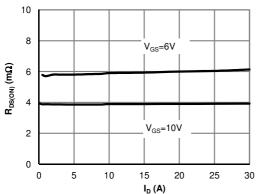
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



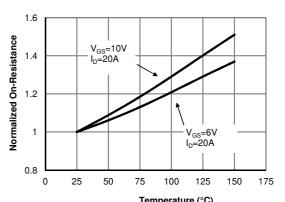
V_{DS} (Volts) Fig 1: On-Region Characteristics (Note E)



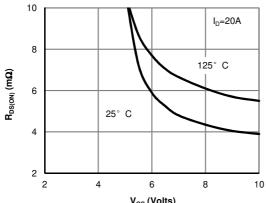
V_{GS}(Volts)
Figure 2: Transfer Characteristics (Note E)



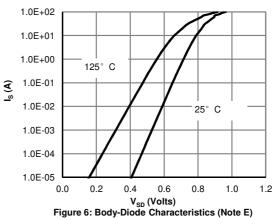
 $\rm I_D\left(A\right)$ Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)



Temperature (°C)
Figure 4: On-Resistance vs. Junction Temperature
(Note E)

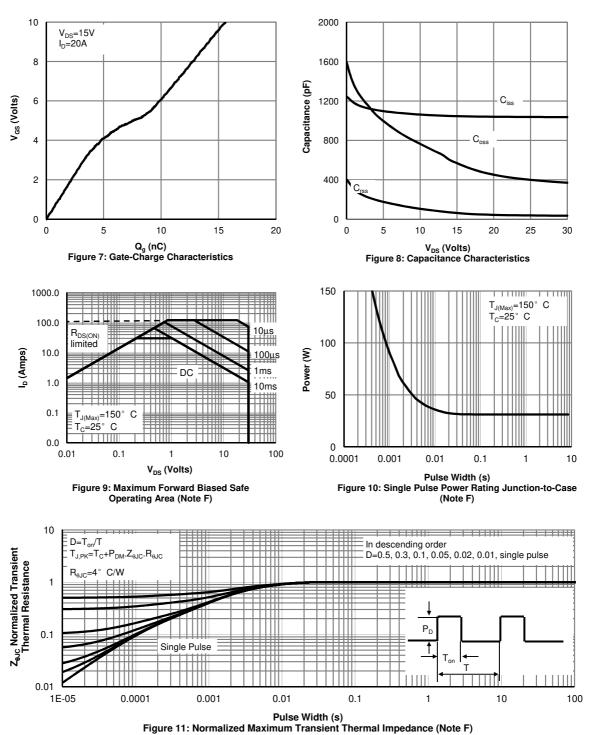


V_{GS} (Volts)
Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)



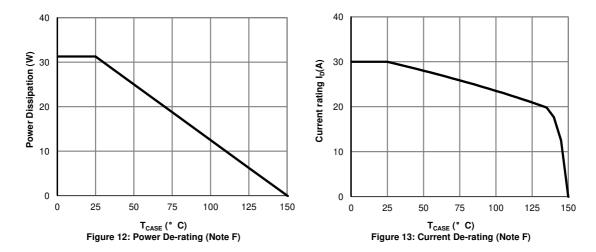


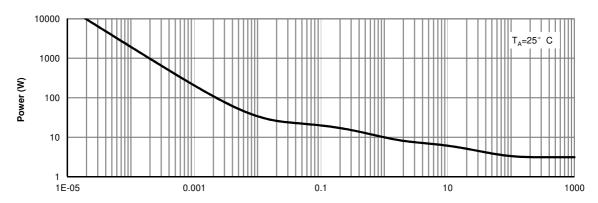
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



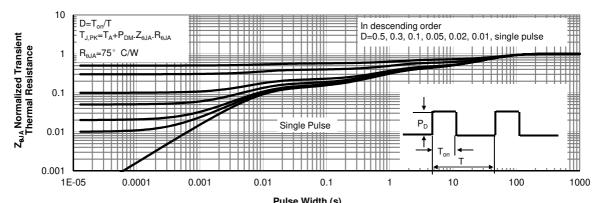


TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





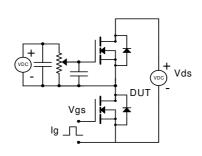
Pulse Width (s)
Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)

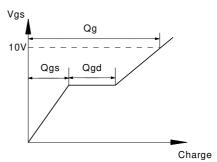


Pulse Width (s)
Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)

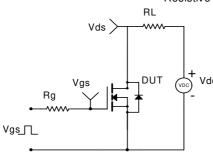


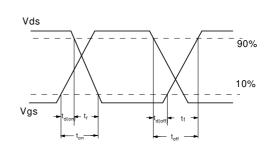
Gate Charge Test Circuit & Waveform



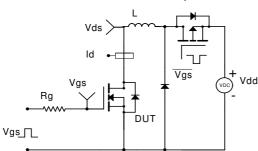


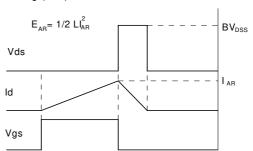
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

